QPL1002 0.03 – 3 GHz GaN LNA

General Description

The QPL1002 is a wideband cascode low noise amplifier fabricated on Qorvo's 0.25um GaN on SiC production process. This cascode LNA is robust to 5W of input power with 17dB typical gain and 1.2dB noise figure from 0.03 GHz to 3.0 GHz. The QPL1002 is ideal for wideband communication applications across defense and commercial markets.

The QPL1002 is housed in a low-cost 16 lead 3x3 plastic overmolded QFN package. It is fully matched to 50 ohms on both RF ports eliminating the need for impedance matching typical of LNAs in this band. DC blocks and bias chokes are required given the low frequency nature of this amplifier.

Lead-free and RoHS compliant.

Evaluation boards are available upon request.



Functional Block Diagram



Product Features

- Frequency Range: 0.03-3 GHz
- Noise Figure: 1.2 dB
- Small Signal Gain: 17 dB
- P1dB: 23 dBm
- Output TOI: 30 dBm (@Pout =18 dBm / tone)
- High Input Power Survivability: 37 dBm
- Bias: VD = 12 V, IDQ = 50 mA, VG = -2.5 V, VC = 2V
- Plastic 3x3 -16L QFN Overmold Package
- Package Dimensions: 3.0 x 3.0 x 0.85 mm

Performance is typical across frequency. Please reference electrical specification table and data plots for more details.

Applications

- Commercial and Military Radar
- Radio Communications
- Electronic Warfare

Pad Configuration

| Pad No. | Label |
|---------------------|-----------|
| Slug | GND |
| 3 | RF Input |
| 6 | VC |
| 10 | RF Output |
| 1, 2, 4, 5, 7, 8, 9 | N/C |
| 11 - 16 | N/C |

Ordering Information

| Part No. | ECCN | Description |
|------------|-------|------------------------------------|
| QPL1002 | EAR99 | 0.03 - 3.0 GHz Low Noise Amplifier |
| QPL1002EVB | EAR99 | QPL1002 Low Noise Amplifier EVB |

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Absolute Maximum Ratings

| Parameter | Value |
|--------------------------------------|---------------|
| Drain Voltage (VD) | 20.0 V |
| Drain Current (IDQ) | 300 mA |
| Gate Voltage Range (VG) | 0 to −5 V |
| Gate Current (IG) | 20 mA |
| Control Voltage (VC) | -5V to VD |
| Control Current (IC) | 20 mA |
| RF Input Power (50 Ω, 85 °C) | 37 dBm |
| Channel Temperature, T _{CH} | 275 °C |
| Mounting Temperature (30 seconds) | 260 °C |
| Storage Temperature | −55 to 150 °C |

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

| Parameter | Value | |
|--------------------------------------|--------------|--|
| Drain Voltage | 12 V | |
| Drain Current (quiescent, IDQ) 50 mA | | |
| Gate Voltage (typical) | -2.5 V | |
| Control Voltage (typical) | +2 V | |
| Operating Temperature Range | −40 to 85 °C | |

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

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Electrical Specifications

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| Test conditions, unless otherwise noted: $VD = 12 V$, $VC = +2V$, $IDQ = 50$ | mA, 25 °C. D | ata de-embed | ded to device | reference plane |
|--|--------------|--------------|---------------|-----------------|
| Parameter | Min | Typical | Max | Units |
| Frequency | 0.03 | | 3 | GH7 |

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| Frequency | 0.03 | | 3 | GHz |
|---|------|--------|----|-------|
| Small Signal Gain | | 17 | | dB |
| Noise Figure | | 1.2 | | dB |
| 1-dB Compression Point | | 23 | | dBm |
| Input Return Loss | | 12 | | dB |
| Output Return Loss | | 11 | | dB |
| Robustness (@ 50 Ohm, 85C) | | 37 | | dBm |
| Output TOI (@Pout=18 dBm/tone, 10 MHz tone spacing) | | 30 | | dBm |
| Gain Temperature Coefficient | | -0.017 | | dB/°C |
| Recommended Darin Voltage | | 12 | 15 | V |

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Performance Plots – Small Signal

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 50mA, 25C Data de-embedded to device reference plane



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Performance Plots – Small Signal

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 50mA, 25C Data de-embedded to device reference plane













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Performance Plots – Nose Figure

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 50mA, 25C Data de-embedded to device reference plane





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Performance Plots – Power

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 50mA, 25C Data de-embedded to device reference plane



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Performance Plots – Power Sweep

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 40mA, 25C Data de-embedded to device reference plane



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Performance Plots – Linearity

Test Conditions unless otherwise stated: VD = 12V, VC = +2V, IDQ = 50mA, 25C Data de-embedded to device reference plane Tone spacing 10MHz, Pin = 4 dBm / tone







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Application Circuit



Bias-up Procedure

- 1. Set I_{D} limit to 300 mA, IG and IC limits to 20 mA
- 2. Set VG to –5 V
- 3. Set VD +12 V
- 4 Set VC = +2V
- 5. Adjust VG more positive until IDQ = 50 mA (- 2.5 V typical)
- 6. Apply RF signal

Bias-down Procedure

- 1. Turn off RF signal
- 2. Reduce VG to –5 V, ensure IDQ ~ 0mA
- 3. Set VC to 0V
- 4. Set VD to 0V
- 5. Turn off VC, VD, VG supplies

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Evaluation Board and Assembly



RF Layer is 0.008" thick Rogers Corp. RO4003C ($\epsilon_r = 3.35$). Metal layers are 0.5 oz. copper. The microstrip line at the connector interface is optimized for the Southwest Microwave end launch connector 1492-04A-5.

All data de-embedded to the device reference plane (shown).

Bill of Materials

| Ref. Des. | Component | Value | Manuf. | Part Number |
|----------------|-------------------|--|---------|-------------|
| C2, C5-C7, C10 | Surface Mount Cap | CAP, 0.01UF +/-10% 50V 0402 X7R, ROHS | Various | |
| L1, L2 | Surface Mount Ind | IND, 560 nH, 5%, 550mA, W/W 0603, ROHS | Various | |
| R6 | Surface Mount Res | RES, 10 Ohm, 5% 0402, 1/16W, ROHS | Various | |
| R2 | Surface Mount Res | RES, 10 Ohm, 5%, 0402, 1/16W, ROHS, | Various | |

Mechanical Drawing & Pad Description



Dimensions in mm Part Marking: L1002: Part Number YY = Part Assembly Year MM = Part Assembly Month MXXX = Batch ID

| Pin Number | Label | Description |
|------------------------|------------|--------------------------------|
| Slug | GND | GROUND |
| 1, 2, 4, 5, 7-9, 11-16 | N/C | No Internal Connection |
| 3 | RFIN / VG | RF Input, DC Coupled to Gate |
| 10 | RFOUT / VD | RF Output, DC Coupled to Drain |
| 6 | VC | Control Voltage |

Thermal and Reliability Information

| Parameter | Test Conditions | Value | Units |
|---|--|---------|-------|
| Thermal Resistance (θ_{JC}) ⁽¹⁾ | $T_{\text{base}} = 85^{\circ}\text{C}, V_{\text{D}} = 12 \text{ V}, \text{ IDQ} = 50 \text{ mA}$ | 11.34 | °C/W |
| Channel Temperature (T _{CH}) | Quiescent/Small Signal operation | 91.8 | °C |
| Median Lifetime (T _M) | $P_{DISS} = 0.6 W$ | 3.31E12 | Hrs |

Notes:

1. Thermal resistance is measured to back of the package.

Median Lifetime





Solderability

Compatible with the latest version of J-STD-020, Lead-free solder, 260 °C

Recommended Soldering Temperature Profile



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Handling Precautions

| Parameter | Rating | Standard | | |
|--------------------------------|----------|---------------------------------------|--|----------------------------------|
| ESD-Human Body Model (HBM) | Class 1A | ESDA/JEDEC JS-001-2012 | | Caution! ESD-Sensitive Device |
| ESD-Charged Device Model (CDM) | TBD | ESDA/JEDEC JS-002-2014 | | |
| MSL – Convection Reflow 260 °C | TBD | JEDEC standard IPC/JEDEC J-STD-020 | | |

RoHS Compliance

This product is compliant with the 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment), as amended by Directive 2015/863/EU. This product also has the following attributes:

- Lead Free
- Antimony Free
- TBBP-A (C15H12Br402) Free
- PFOS Free
- SVHC Free
 - Qorvo Green





Contact Information

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